



Shantou Huashan Electronic Devices Co.,Ltd.

NPN SILICON TRANSISTOR

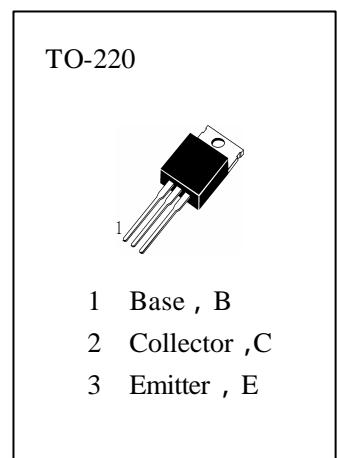
HC5039

APPLICATIONS

high Voltage power switch switching Application.

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

T_{stg}	—Storage Temperature.....	-65~150
T_j	—Junction Temperature.....	150
P_c	—Collector Dissipation($T_c=25^\circ C$).....	70W
V_{CBO}	—Collector-Base Voltage.....	800V
V_{CEO}	—Collector-Emitter Voltage.....	400V
V_{EBO}	—Emitter-Base Voltage.....	7V
I_c	—Collector Current (DC)	5A
I_{CP}	—Collector Current(Pulse).....	10A
I_b	—Base Current.....	3A



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Symbol	Characteristics	Min	Typ	Max	Unit	Test Conditions
BVCBO	Collector-Base Breakdown Voltage	800			V	$I_c=1mA, I_e=0$
BVCEO	Collector-Emitter Breakdown Voltage	400			V	$I_c=5mA, I_b=0$
BVEBO	Emitter-Base Breakdown Voltage	7			V	$I_e=1mA, I_c=0$
ICBO	Collector Cut-off Current			10	μA	$V_{CB}=500V, I_e=0$
IEBO	Emitter Cut-off Current			10	μA	$V_{EB}=7V, I_c=0$
HFE	*DC Current Gain	10				$V_{CE}=5V, I_c=0.3A$
VCE(sat)	*Collector- Emitter Saturation Voltage			1.5	V	$I_c=2.5A, I_b=0.5A$
VBE(sat)	*Base-Emitter Saturation Voltage			2.0	V	$I_c=2.5A, I_b=0.5A$
fr	Current Gain-Bandwidth Product		10		MHz	$V_{CE}=5V, I_c=0.1A$
Cob	Output Capacitance			40	pF	$V_{CB}=10V, f=1MHz$
ton	Turn On Time			1	μS	
tstg	Storage Time			3	μS	$V_{cc}=150V, I_c=2.5A, I_{b1}=-I_{b2}=0.5A, R_L=60$
tf	Fall Time			0.8	μS	

*Pulse Test : PW 300 μs , Duty cycle 2% Pulse



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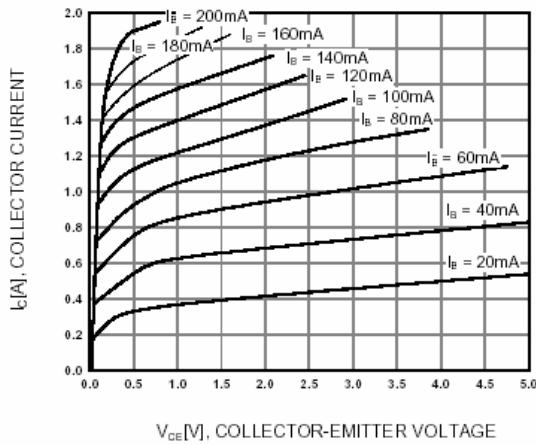


Figure 1. Static Characteristic

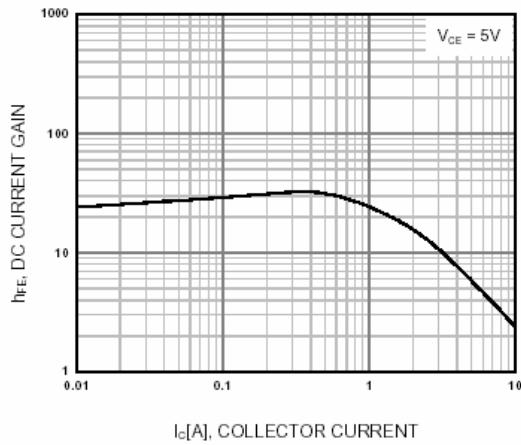


Figure 2. DC current Gain

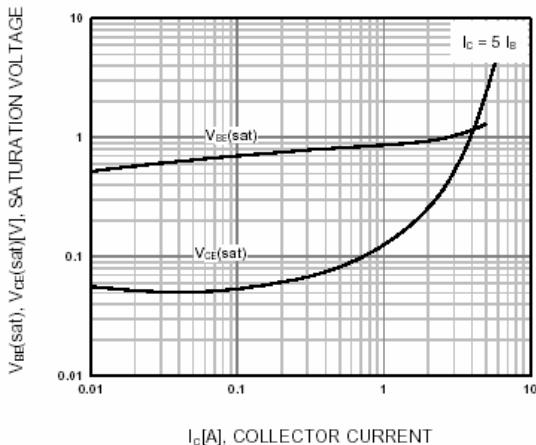


Figure 3. Base-Emitter Saturation Voltage
Collector-Emitter Saturation Voltage

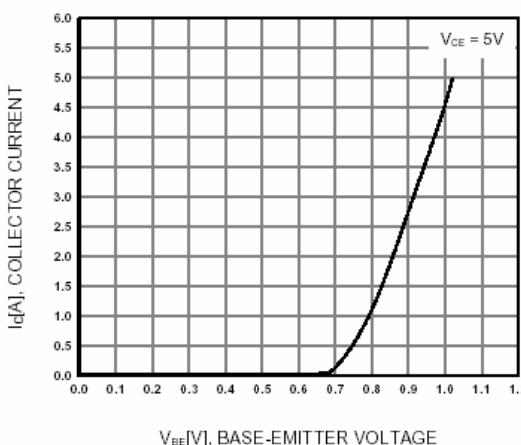


Figure 4. Base-Emiter On Voltage

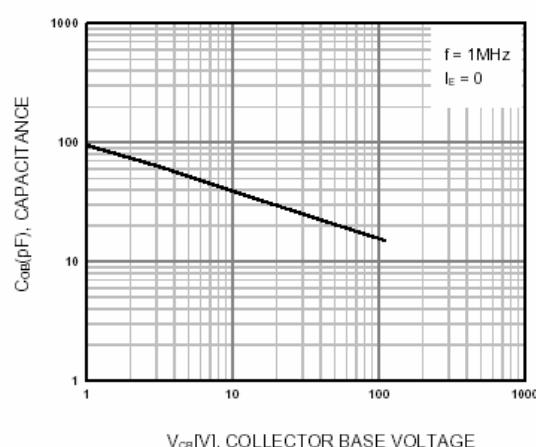


Figure 5. Collector Output Capacitance

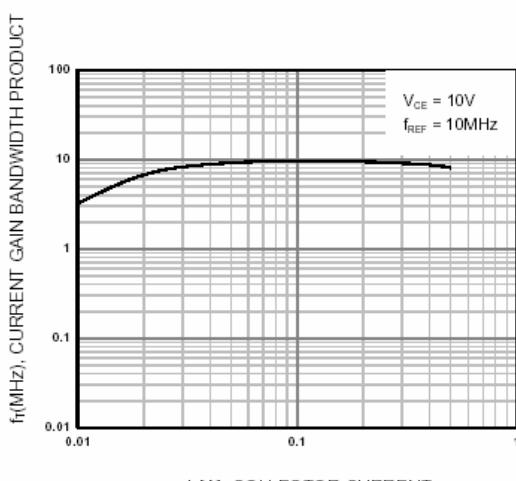


Figure 6. Current Gain Bandwidth Product



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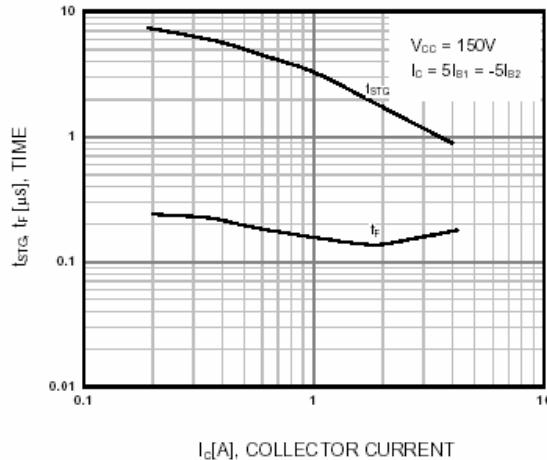


Figure 7. Switching Time

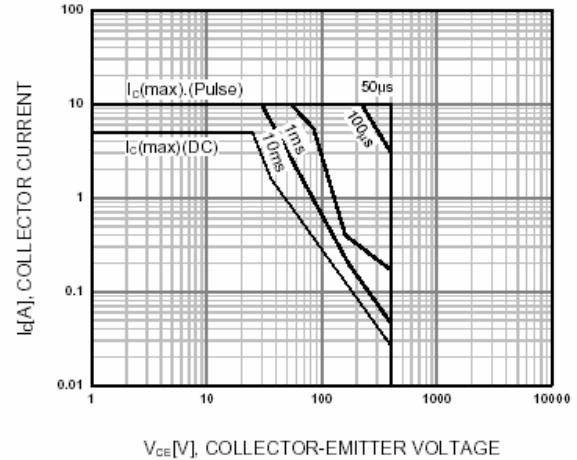


Figure 8. Safe Operating Area

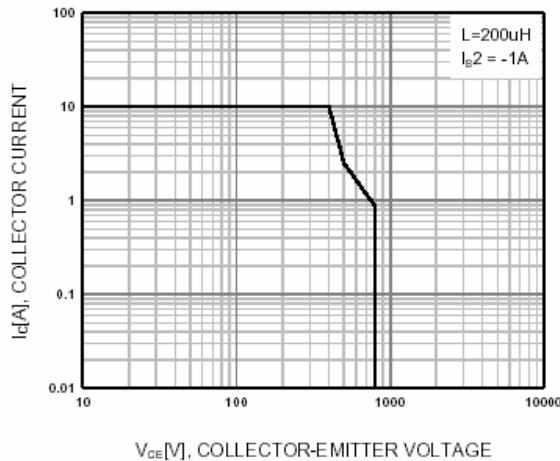


Figure 9. Reverse Bias Safe Operating Area

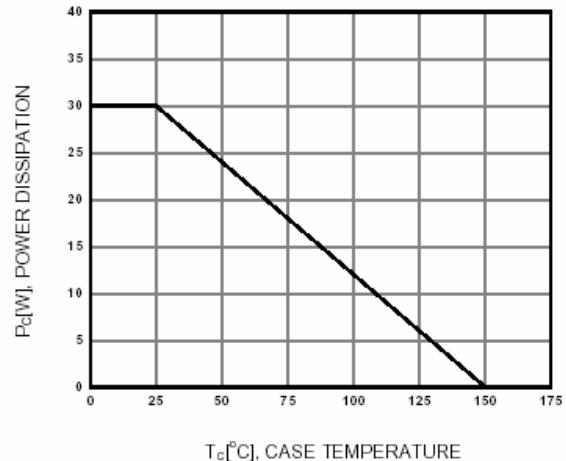


Figure 10. Power Derating